

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/686,398	MURPHY ET AL.	
Examiner	Art Unit	
Tam M. Nguyen	1764	

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	SEAR	CHED	
Class	Subclass	Date	Examiner
208	58 88 89 18 134 137 209 245H 60 61 78	8/1/2006	TN
585	310 734 739	8/1/2006	tn
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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(INCLUDING SEARCH	DATE	EXMR
EAST	8/1/2006	TN
inventors searched	8/1/2006	TN
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